Notice of References Cited Application/Control No. | Applicant(s)/Patent Under Reexamination CHANG ET AL. | Examiner | Art Unit | Page 1 of 1

U.S. PATENT DOCUMENTS

*	_	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,776,864	08-2004	Hahn et al.	156/230
*	В	US-6,653,625	11-2003	Andersson et al.	250/288
*	С	US-5,840,388	11-1998	Karger et al.	428/36.91
*	D	US-6,372,353	04-2002	Karger et al.	428/447
*	E	US-6,488,831	12-2002	Hayes, Mark A.	204/454
*	F	US-7,172,682	02-2007	Dordick et al.	204/450
*	G.	US-2003/0042140	03-2003	Hayes, Mark A.	204/454
*	Н	US-2005/0266582	12-2005	Modlin et al.	436/164
	-	US-			
	J	US-			
	Κ	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	2					
	0					,
	Р					
	Q					
	R					•
	S	•				
	Т					,

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	υ	
	>	
	w	
	x	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYYY format are publication dates. Classifications may be US or foreign.